TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

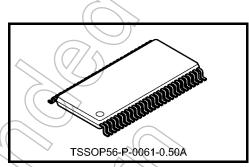
# TC74VCX162821FT

Low-Voltage 20-Bit D-Type Flip-Flop with 3.6-V Tolerant Inputs and Outputs

The TC74VCX162821FT is a high-performance CMOS 20-bit D-type flip-flop. Designed for use in 1.8-V, 2.5-V or 3.3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

It is also designed with overvoltage tolerant inputs and outputs up to  $3.6\ V.$ 

The device is byte controlled with each byte functioning identically, but independent of the other. Control pins can be shorted together to obtain full 20-bit operation. The following description applies to each byte. The twenty flip-flops will store the state of their individual D inputs that meet the setup and hold time requirements on the LOW-to-HIGH Clock (CK)



Weight: 0.25 g (typ.)

transition. When the OE input is high, the outputs are in a high-impedance state. This device is designed to be used with 3-state memory address drivers, etc.

The  $26-\Omega$  series resistor helps reducing output overshoot and undershoot without external resistor. All inputs are equipped with protection circuits against static discharge.

#### **Features**

- $26-\Omega$  series resistors on outputs.
- Low-voltage operation: V<sub>CC</sub> = 1.8 to 3.6 V
- High-speed operation:  $t_{pd} = 4.4 \text{ ns (max)} (V_{CC} = 3.0 \text{ to } 3.6 \text{ V})$

$$t_{pd} = 5.8 \text{ ns (max) (VCC} = 2.3 \text{ to } 2.7 \text{ V)}$$

$$: t_{pd} = 9.8 \text{ ns (max) (V}_{CC} = 1.8 \text{ V})$$

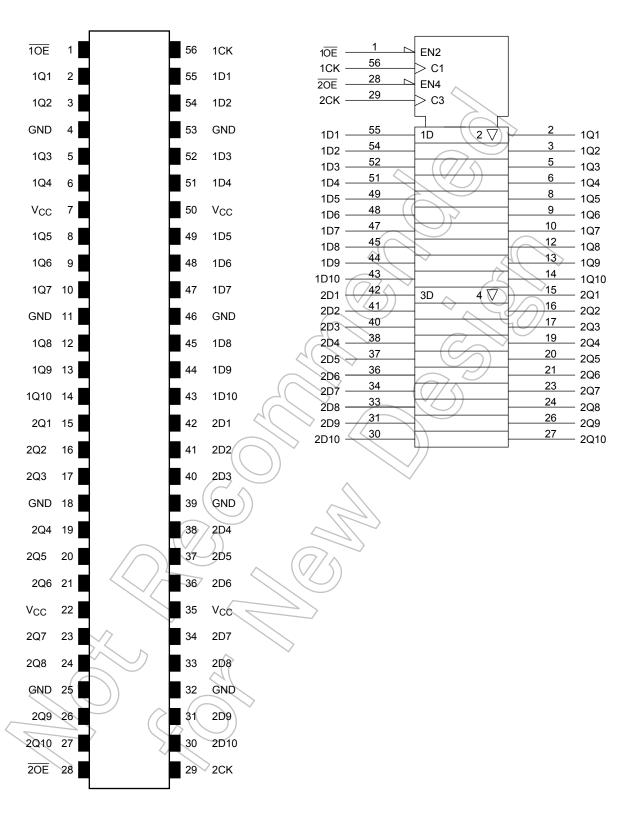
- Output current:  $I_{OH}/I_{OL} = \pm 12 \text{ mA (min)} (V_{CC} = 3.0 \text{ V})$ 
  - $: I_{OH}/I_{OL} = \pm 8 \text{ mA (min)} (V_{CC} = 2.3 \text{ V})$
  - $: I_{OH}/I_{OL} = \pm 4 \text{ mA (min) (V}_{CC} = 1.8 \text{ V)}$
- Latch-up performance: -300 mA
- ESD performance: Machine model  $\geq \pm 200 \text{ V}$

Human body model  $\geq \pm 2000 \text{ V}$ 

- Package: TSSOP
- 3.6-V tolerant function and power-down protection provided on all inputs and outputs

### Pin Assignment (top view)

### **IEC Logic Symbol**



#### **Truth Table**

	Outputs		
1 <del>OE</del>	1CK	1D1-1D10	1Q1-1Q10
Н	Х	X	Z
L	$\rightarrow$	Х	Qn
L		L	L
L		Н	Н

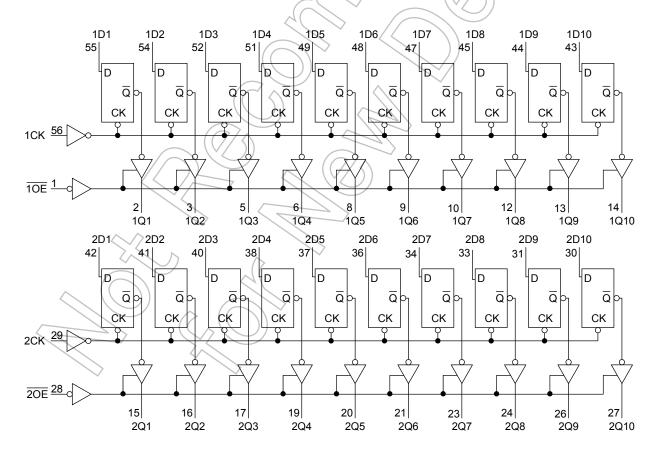
	Outputs		
2 <del>OE</del>	2CK	2D1-2D10	2Q1-2Q10
Н	X	X	Z
L	$\rightarrow$	Х	Qn
L		L	L
L		Н	Н

X: Don't care

Z: High impedance

Qn: No change

## **System Diagram**



### **Absolute Maximum Ratings (Note 1)**

Characteristics	Symbol	Rating	Unit	
Power supply voltage	V <sub>CC</sub>	-0.5 to 4.6	V	
DC input voltage	V <sub>IN</sub>	-0.5 to 4.6	V	
		-0.5 to 4.6 (Note 2)	\ \	
DC output voltage	V <sub>OUT</sub>	-0.5 to V <sub>CC</sub> + 0.5 (Note 3)	V	
Input diode current	I <sub>IK</sub>	-50	mA	
Output diode current	lok	±50 (Note 4)	mA )	
DC output current	lout	±50	mA	
Power dissipation	P <sub>D</sub>	400	mW	
DC V <sub>CC</sub> /ground current per supply pin	I <sub>CC</sub> /I <sub>GND</sub>	±100	mA	
Storage temperature	T <sub>stg</sub>	-65 to 150	ုင	

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc).

Note 2: OFF-state

Note 3: High or low state. IOUT absolute maximum rating must be observed.

Note 4:  $V_{OUT} < GND$ ,  $V_{OUT} > V_{CC}$ 

## Operating Ranges (Note 1)

Characteristics	Symbol	Rating	Unit	
Power supply voltage		1.8 to 3.6	V	
rower supply voltage	ycc /	1.2 to 3.6 (Note 2)	V	
Input voltage	V <sub>IN</sub>	-0.3 to 3.6	٧	
Output voltage	Vout	0 to 3.6 (Note 3)	V	
Output voltage	V001	0 to V <sub>CC</sub> (Note 4)	v	
	_	±12 (Note 5)		
Output current	IOH/IOL	±8 (Note 6)	mA	
$\wedge$ (())		±4 (Note 7)		
Operating temperature	Topr	-40 to 85	°C	
Input rise and fall time	dt/dv	0 to 10 (Note 8)	ns/V	

Note 1: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either V<sub>CC</sub> or GND.

Note 2: Data retention only

Note 3: OFF-state

Note 4: High or low state

Note 5:  $V_{CC} = 3.0 \text{ to } 3.6 \text{ V}$ 

Note 6:  $V_{CC} = 2.3 \text{ to } 2.7 \text{ V}$ 

Note 7:  $V_{CC} = 1.8 \text{ V}$ 

Note 8:  $V_{IN} = 0.8$  to 2.0 V,  $V_{CC} = 3.0$  V



### **Electrical Characteristics**

## DC Characteristics (Ta = -40 to $85^{\circ}$ C, 2.7 V < $V_{CC} \le 3.6$ V)

Characteri	stics	Symbol	Test C	ondition	V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>	-	_	2.7 to 3.6	2.0	_	V
input voitage	L-level	V <sub>IL</sub>	_	_	2.7 to 3.6		0.8	٧
				I <sub>OH</sub> = -100 μA	2.7 to 3.6	V <sub>CC</sub> - 0.2	_	
	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	$I_{OH} = -6 \text{ mA}$	//2.7	2.2		
				$I_{OH} = -8 \text{ mA}$	3.0	2.4		
Output voltage				I <sub>OH</sub> = -12 mA	3.0	2.2		٧
			$V_{IN} = V_{IH} \text{ or } V_{IL}$ $I_{OL} = 81$	$I_{OL} = 100 \mu\text{A}$	2.7 to 3.6		0.2	
	L-level	V <sub>OL</sub>		I <sub>OL</sub> = 6 mA	2.7	4	0.4	
	L-ICVCI	VOL		$I_{OL} = 8 \text{ mA}$	3.0	\_\	0.55	
				I <sub>OL</sub> ≠ 12 mA	3.0((	D) <del>-</del>	0.8	
Input leakage current	t	I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		2.7 to 3.6	4	±5.0	μΑ
3-state output OFF s	tate current	I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = 0 to 3.6 V		2.7 to 3.6	) 	±10.0	μΑ
Power-off leakage cu	ırrent	loff	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V			_	10.0	μА
Quiescent supply current		loo	$V_{IN} = V_{CC}$ or GND		2.7 to 3.6	_	20.0	
		Icc	V <sub>CC</sub> ≤ (V <sub>IN</sub> , V <sub>OUT</sub> ) ≤ 3.6 V		2.7 to 3.6	_	±20.0	μΑ
Increase in I <sub>CC</sub> per in	nput	Δlcc	$V_{IH} = V_{CC} - 0.6 \text{ V}$		2.7 to 3.6	_	750	

## DC Characteristics (Ta = -40 to 85°C, 2.3 V ≤ V<sub>CC</sub> ≤ 2.7 V)

Characteristi	cs	Symbol	Test Co	ondition	V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>			2.3 to 2.7	1.6	_	V
Input voltage	Level	VI⊩		<u>)</u>	2.3 to 2.7	_	0.7	V
		>		I <sub>OH</sub> = -100 μA	2.3 to 2.7	V <sub>CC</sub> - 0.2	_	
	H-level	V <sub>OH</sub>	VIN = VIH or VIL	$I_{OH} = -4 \text{ mA}$	2.3	2.0	_	
	$\backslash \cap$		$\wedge$	$I_{OH} = -6 \text{ mA}$	2.3	1.8	_	
Output voltage				I <sub>OH</sub> = -8 mA	2.3	1.7	_	V
				I <sub>OL</sub> = 100 μA	2.3 to 2.7	_	0.2	
	L-level	VoL	$V_{IN} = V_{IH}$ or $V_{IL}$	I <sub>OL</sub> = 6 mA	2.3	_	0.4	
		2		I <sub>OL</sub> = 8 mA	2.3	_	0.6	
Input leakage current	4	JIN	V <sub>IN</sub> = 0 to 3.6 V		2.3 to 2.7	_	±5.0	μΑ
3-state output OFF state	e current	loz	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = 0$ to 3.6 V		2.3 to 2.7	_	±10.0	μА
Power-off leakage curre	ent	I <sub>OFF</sub>	$V_{IN}$ , $V_{OUT} = 0$ to 3.6 V		0	_	10.0	μА
Ovice and average average		laa	V <sub>IN</sub> = V <sub>CC</sub> or GND		2.3 to 2.7	_	20.0	^
Quiescent supply curre	111	Icc	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3$	.6 V	2.3 to 2.7	_	±20.0	μА

## DC Characteristics (Ta = -40 to 85°C, 1.8 V $\leq$ V $_{CC}$ < 2.3 V)

Characteristi	cs	Symbol	Test Co	ondition	V <sub>CC</sub> (V)	Min	Max	Unit
Input voltage	H-level	V <sub>IH</sub>	_	_	1.8 to 2.3	0.7 × V <sub>CC</sub>	_	V
input voltage	L-level	V <sub>IL</sub>	_	_	1.8 to 2.3	_	0.2 × V <sub>CC</sub>	V
	H-level	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>II</sub>	I <sub>OH</sub> = -100 μA	1.8	V <sub>CC</sub> - 0.2	_	
Output voltage				I <sub>OH</sub> = -4 mA	7/1,8	1.4	_	V
	L-level		/ <sub>OL</sub> V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 100 μA	1.8	_	0.2	
	L-ievei	VOL		I <sub>OL</sub> = 4 mA	1.8	_	0.3	
Input leakage current		I <sub>IN</sub>	V <sub>IN</sub> = 0 to 3.6 V		<b>1.8</b>	-	±5.0	μΑ
3-state output OFF state current I <sub>O</sub>		l <sub>OZ</sub>	$V_{IN} = V_{IH}$ or $V_{IL}$ $V_{OUT} = 0$ to 3.6 V	4	1.8	<u> </u>	±10.0	μА
Power-off leakage curr	ent	loff	V <sub>IN</sub> , V <sub>OUT</sub> = 0 to 3.6 V		0	7-/	> 10.0	μΑ
Quincoant auguly augrant		las	V <sub>IN</sub> = V <sub>CC</sub> or GND		1.8		20.0	^
Quiescent supply curre	an,	Icc	$V_{CC} \le (V_{IN}, V_{OUT}) \le 3.$	6 V	1.8	90	±20.0	μА

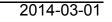
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## AC Characteristics (Ta = –40 to 85°C, input: $t_r = t_f$ = 2.0 ns, $C_L$ = 30 pF, $R_L$ = 500 $\Omega$ ) (Note 1)

Characteristics	Symbol	Test Condition	V <sub>CC</sub> (V)	Min	Max	Unit
			1.8	100	_	
Maximum clock frequency	f <sub>max</sub>	Figure 1, Figure 2	2.5 ± 0.2	200	_	MHz
			$3.3 \pm 0.3$	250	_	
B 6 11 6			1.8	1.5	9.8	
Propagation delay time	t <sub>pLH</sub>	Figure 1, Figure 2	$2.5 \pm 0.2$	0.8	5.8	ns
(CK-Q)	t <sub>pHL</sub>	< (C	$3.3 \pm 0.3$	0.6	4.4	
	4	7/	1.8	1.5	9.8	
3-state output enable time	t <sub>pZL</sub>	Figure 1, Figure 3	2.5 ± 0.2	0.8	5.7	ns
	<sup>t</sup> pZH		$3.3 \pm 0.3$	0.6	4.2	
	t <sub>pLZ</sub>	4(>>	1.8	1.5	8.8	
3-state output disable time		Figure 1, Figure 3	$2.5\pm0.2$	0.8	4.9	ns
	t <sub>pHZ</sub>	((//5)	$3.3 \pm 0.3$	0.6	4.2	
Minimum pulse width	t <sub>W (H)</sub>		1.8	4.0	/ —	
(CK)		Figure 1, Figure 2	$2.5 \pm 0.2$	1.5	_	ns
(Oity	t <sub>W (L)</sub>	4(>)	3.3 ± 0.3	1.5	_	
			1.8	2.5	_	
Minimum setup time	ts	Figure 1, Figure 2	2.5 ± 0.2	1.5	_	ns
			$3.3 \pm 0.3$	1.5	_	
	/		1.8	1.0	_	
Minimum hold time	t <sub>h</sub>	Figure 1, Figure 2	$2.5\pm0.2$	1.0	_	ns
	0		$3.3 \pm 0.3$	1.0	_	
	tostH		1.8	_	0.5	
Output to output skew	toshi	(Note 2)	$2.5 \pm 0.2$	_	0.5	ns
	03111		$3.3 \pm 0.3$	_	0.5	

Note 1: For  $C_L = 50$  pF, add approximately 300 ps to the AC maximum specification.

Note 2: Parameter guaranteed by design.  $(t_{OSLH} = |t_{DLHm} - t_{DLHn}|, t_{OSHL} = |t_{DHLm} - t_{DHLn}|)$ 



### **Dynamic Switching Characteristics**

(Ta = 25°C, input:  $t_r = t_f$  = 2.0 ns,  $C_L$  = 30 pF,  $R_L$  = 500  $\Omega$ )

Characteristics	Symbol	Test Condition			Тур.	Unit
Characteristics	Symbol	Test C	Solidition	V <sub>CC</sub> (V)	τyp.	Offic
		V <sub>IH</sub> = 1.8 V, V <sub>IL</sub> = 0 V	(Note)	1.8	0.15	
Quiet output maximum dynamic V <sub>OL</sub>	V <sub>OLP</sub>	V <sub>IH</sub> = 2.5 V, V <sub>IL</sub> = 0 V	(Note)	2.5	0.25	V
		V <sub>IH</sub> = 3.3 V, V <sub>IL</sub> = 0 V	(Note)	3.3	0.35	
		V <sub>IH</sub> = 1.8 V, V <sub>IL</sub> = 0 V	(Note)	1.8	-0.15	
Quiet output minimum dynamic V <sub>OI</sub>	$V_{OLV}$	V <sub>IH</sub> = 2.5 V, V <sub>IL</sub> = 0 V	(Note)	2.5	-0.25	V
, 01		V <sub>IH</sub> = 3.3 V, V <sub>IL</sub> = 0 V	(Note)	3.3	-0.35	
		V <sub>IH</sub> = 1.8 V, V <sub>IL</sub> = 0 V	(Note)	1.8	1.55	
Quiet output minimum dynamic V <sub>OH</sub>	V <sub>OHV</sub>	V <sub>IH</sub> = 2.5 V, V <sub>IL</sub> = 0 V	(Note)	2.5	2.05	V
		V <sub>IH</sub> = 3.3 V, V <sub>IL</sub> = 0 V	(Note)	3.3	2.65	

Note: Parameter guaranteed by design.

### **Capacitive Characteristics (Ta = 25°C)**

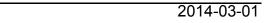
Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Тур.	Unit
Input capacitance	C <sub>IN</sub>		(// 5)	1.8, 2.5, 3.3	6	pF
Output capacitance	CO	-		1.8, 2.5, 3.3	7	pF
Power dissipation capacitance	C <sub>PD</sub>	f <sub>IN</sub> = 10 MHz	(Note)	1.8, 2.5, 3.3	20	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

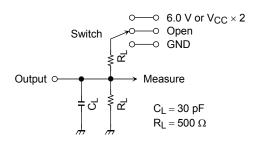
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Average operating current can be obtained by the equation:

 $I_{CC (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/20 \text{ (per bit)}$ 



### **AC Test Circuit**



Parameter	Switch
t <sub>pLH</sub> , t <sub>pHL</sub>	Open
t <sub>pLZ</sub> , t <sub>pZL</sub>	$\begin{array}{cccccccccccccccccccccccccccccccccccc$
t <sub>pHZ</sub> , t <sub>pZH</sub>	GND

Figure 1

### **AC Waveform**

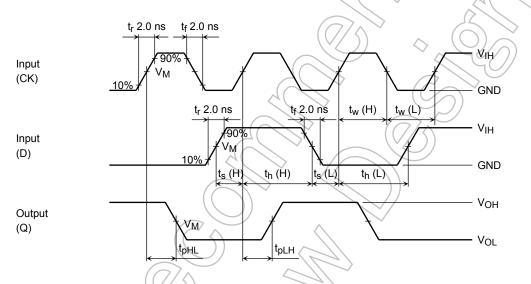


Figure 2 t<sub>pLH</sub>, t<sub>pHL</sub>, t<sub>w</sub>, t<sub>s</sub>, t<sub>h</sub>

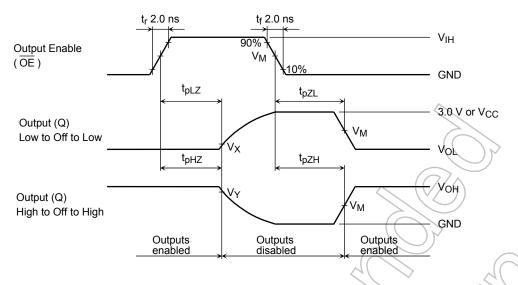
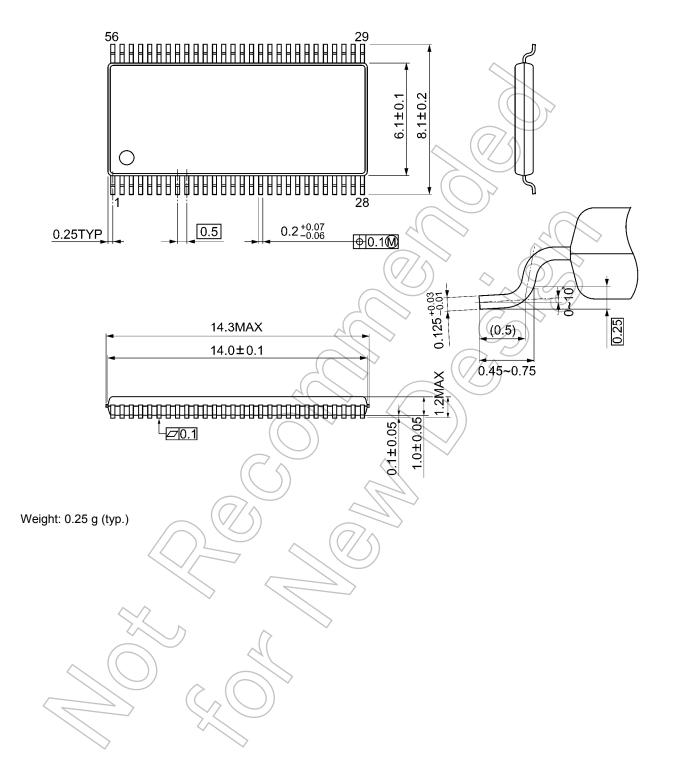


Figure 3  $t_{pLZ}$ ,  $t_{pHZ}$ ,  $t_{pZL}$ ,  $t_{pZH}$ 

Symbol		V <sub>CC</sub>	
Syllibol	$3.3\pm0.3~\textrm{V}$	2.5 ± 0.2 V	1.8 V
V <sub>IH</sub>	2.7 V	VCC	v <sub>cc</sub> (C
$V_{M}$	1.5 V	V <sub>CC</sub> /2	V <sub>CC</sub> /2
VX	V <sub>OL</sub> + 0.3 V	V <sub>OL</sub> + 0.15 V	V <sub>OL</sub> + 0.15 V
$V_{Y}$	V <sub>OH</sub> – 0.3 V	V <sub>OH</sub> – 0.15 V	V <sub>OH</sub> – 0.15 V

### **Package Dimensions**

TSSOP56-P-0061-0.50A Unit: mm



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